

# Process Monitoring: Control and Decision

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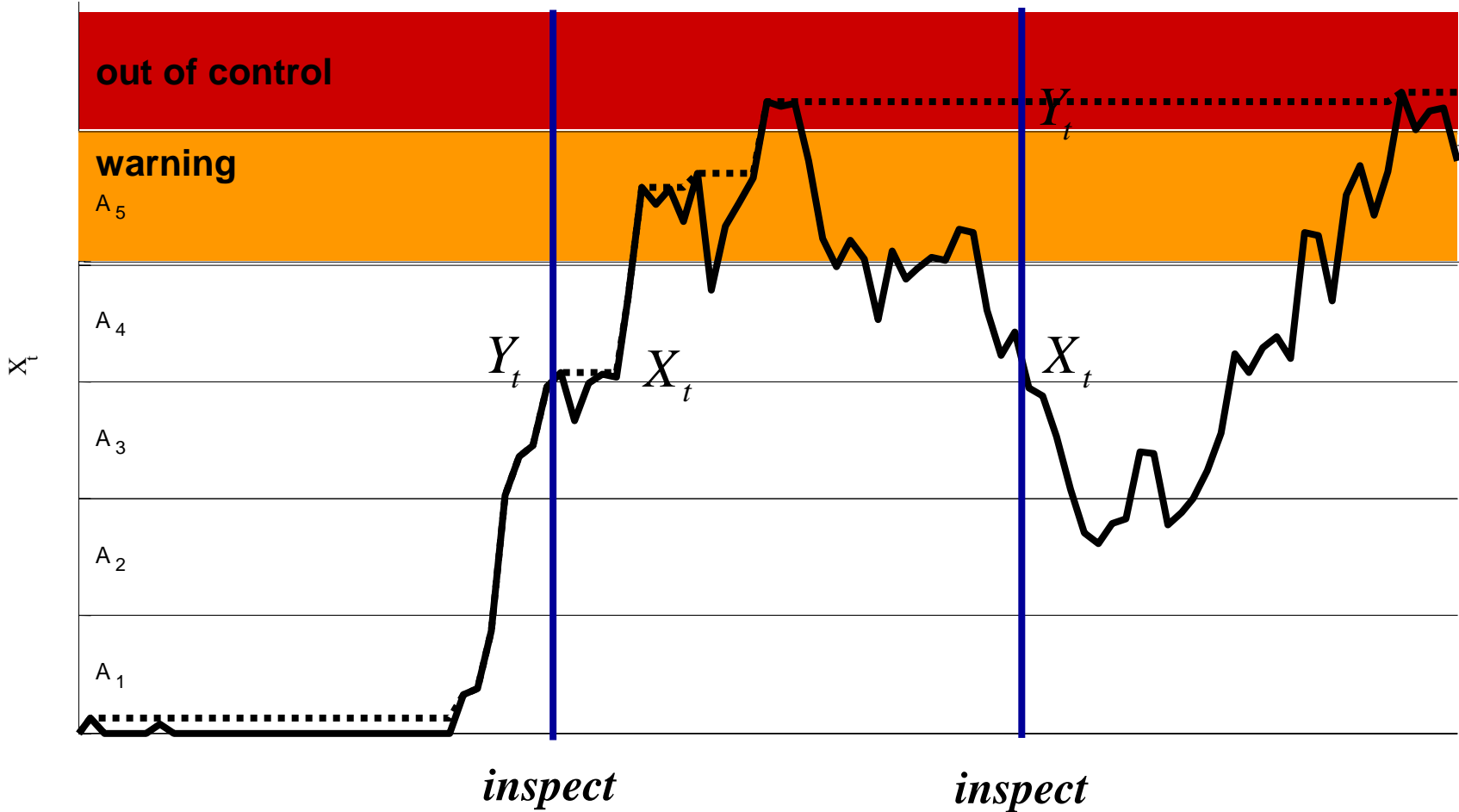
- **concerned with Quality of Service**
- **define effective performance criterion and metrics**
- **base decisions on measured performance**
- **establish the measurement and analysis of the quality of service of systems.**
- **relate quantitative measurements of system QoS with qualitative data on system management processes**

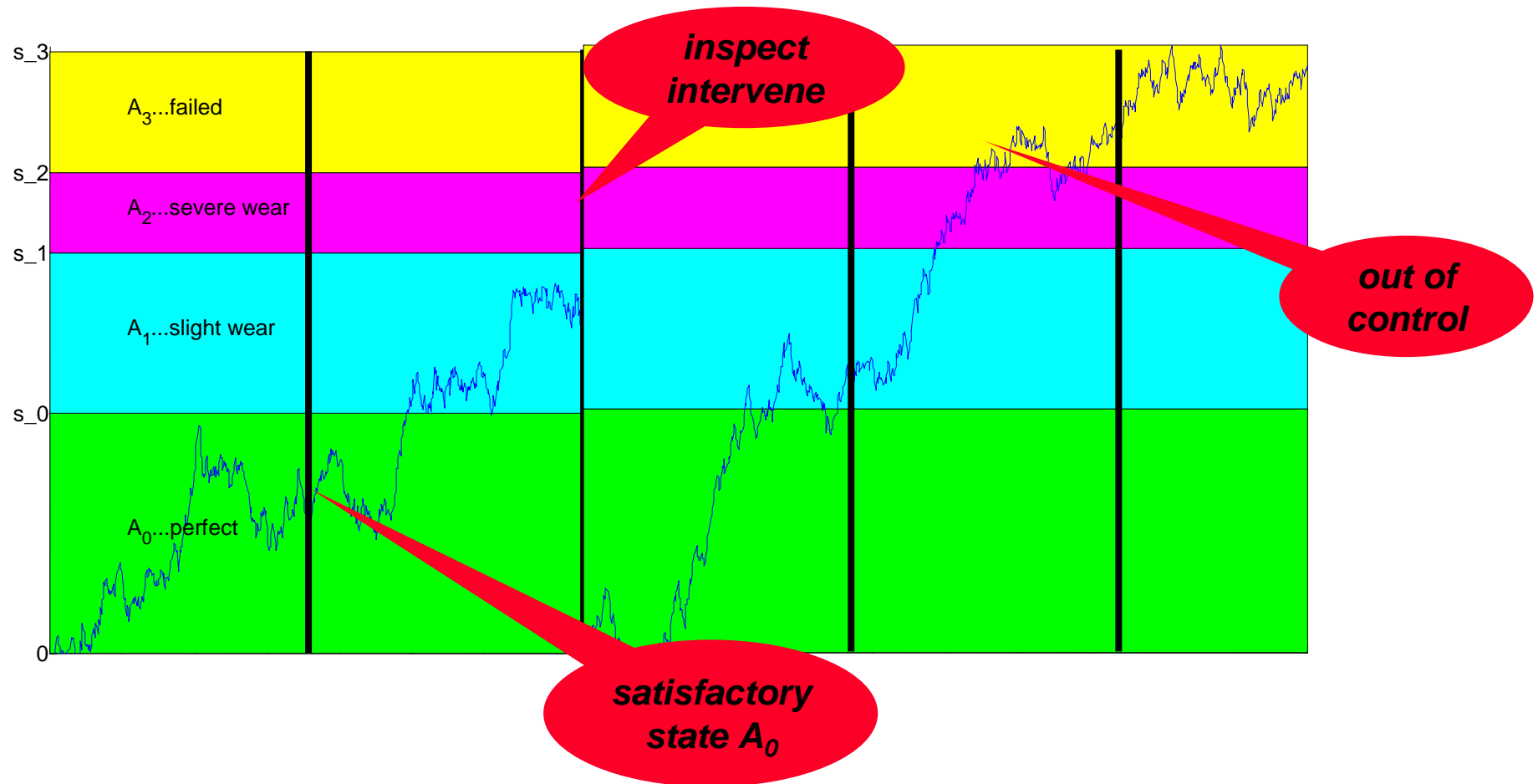
- **develop methods and tools for system management that**
  - inform system management decision making
  - reduce management errors
  - improve the overall dependability of a managed system.
- **To investigate system measurements**
  - as a basis for automatic, dynamic system re-configurations
  - improve performance and dependability.

- what is the optimal time between inspections?
- how great should the intervention be?
- system may be a simple or complex
- process state described stochastic process  $X_t$
- use decision variable  $Y_t$
- may be given or may be constructed  $Y_t = A(X_t)$

- The system is inspected to determine its state
- Decisions driven by excursions of  $(X_t, Y_t)$ 
  - The maximum process  $Y_t = \sup_{0 \leq s \leq t} X_s$
  - multivariate process  $Y_t = \|X_t\|$  (Bessel process)
  - CUSUM  $Y_t = \int_{0 \leq s \leq t} X_s ds$  (Kolmogorov diffusion);
  - errors in measurement  $Y_t = u(X_t, \varepsilon)$
  - covariate processes  $F(X_t | Y_t)$

## Wiener Process





- **The process**  $(X_t, Y_t) \in \Omega \times \mathbb{R}$
- **partitions are** and  $\Omega = \bigcup_{j=1..m} A_j$   $R = \bigcup_{i=1..n} B_i$
- **inspection reveals the state**  $(X_t, Y_t) \in A_i \times B_j$
- **action chosen on basis of set**  $A_i \times B_j$
- **example:** perfect  $A_0$ ; working  $A_i$ ; out of control  $A^*$
- perfect  $B_0$ ; working  $B_i$ ; out of control  $B^*$
- **Hitting times**  $T^{u,v} = \inf \{t | (X_t, Y_t) \in A^* \times B^*\}$   $T^{u,v} \sim G^{u,v}(t)$

**decision maker inspects following policy  $\pi$**

**policy is  $\pi = \{\tau_1, \tau_2, \dots, \tau_n\}$**

**inspection is perfect**

**actions are instantaneous**

**actions are determined by the system state  $(X_t, Y_t)$**

**state  $(X_{t^-}, Y_{t^-}) = (x, y)$  restored to  $(X_{t^+}, Y_{t^+}) = (x', y')$**

**restoration function  $(x', y') = d(x, y)$**

## Cost for a single cycle

$$v_{\tau}(x, y) = c(d(x, y)) + \{v_{\tau}(0, 0) + C_F\} p_F^{d(x, y)} + \int \int_{A_0 B_0} v_{\tau}(u, w) f_{\tau}^{d(x, y)}(u, w) dudw$$

with

$$p_F^{u, v} = G^{u, v}(t)$$

## without discounting

$$v_\tau(x, y) = \inf_{\tau > 0} \left\{ c(d(x, y)) + \{v_\tau(0, 0) + C_F\} p_F^{d(x, y)} + \int_{A_0} v_\tau(u, w) f_\tau^{d(x, y)}(u) dudw \right\}$$

## Discounted cost solution

$$v_\tau(x, y) = \inf_{\tau > 0} \left\{ e^{-r\tau} c(d(x, y)) + \{v_\tau(0, 0) + C_F\} p_{r, F}^{d(x, y)} + \int_{A_0} e^{-ru} v_\tau(u, w) f_\tau^{d(x, y)}(u) dudw \right\}$$

where

$$p_{r, F}^{u, v} = \int_{B_0} e^{-rs} g^{u, v}(s) ds$$

- Fredholm type equations

$$v_{\tau}(x, y) = c_{\tau}(x, y) + \int_{A_0} v_{\tau}(u, w) f_{\tau}^{x,y}(u) dudw$$

- discretized version  $\mathbf{v} = \mathbf{c} + \mathbf{M}\mathbf{v}$
- solution needs care because of singularities in kernel

- joint density of the process and its maximum is

$$f_{\tau}^u(x, y) = \frac{2(2y - x - u)}{\sqrt{2\pi\sigma^6\tau^3}} \exp\left\{-\frac{(x - u - \mu\tau)^2}{2\sigma^2\tau}\right\} \exp\left\{-\frac{2(y - u)(y - x)}{\sigma^2\tau}\right\}$$

- inverse Gaussian hitting time distribution.
- The kernel

$$K_{\tau}^u(x) = \frac{1}{\sqrt{2\pi\sigma^2\tau}} \exp\left\{-\frac{(x - u - \mu\tau)^2}{2\sigma^2\tau}\right\} \times \left[1 - \exp\left\{-\frac{2(s_n - u)(s_n - x)}{\sigma^2\tau}\right\}\right]$$

$$Y_t = \int_{0 \leq s \leq t} X_s ds$$

- **basic process: drift  $\mu$  and volatility  $\sigma$**
- **Integrated process**

$$\mathbf{E}[Y_t] = \frac{1}{2} \mu t^2 \quad \mathbf{V}[Y_t] = \frac{1}{3} \sigma^2 t^3$$

- **the joint density**

$$f_t^{0,0}(x, y) = \frac{\sqrt{3}}{\pi \sigma^2 t^2} \exp \left( -6 \frac{(y - \frac{1}{2} \mu t^2)^2}{\sigma^2 t^3} + 6 \frac{(x - \mu t)(y - \frac{1}{2} \mu t^2)}{\sigma^2 t^2} - 2 \frac{(x - \mu t)^2}{\sigma^2 t} \right)$$

- **degradation is observable with error**  $Y_t = X_t + \varepsilon_t$
- **process is Gamma**  $X_{t_j} - X_{t_i} \sim Ga(\alpha(t_j - t_i), \beta)$
- **error**  $\varepsilon_t \sim N(0, \nu^2) \quad \forall t$
- **transition density**

$$f_{Y_t, X_t | X_0} = f_{Y_t | X_0, X_t} f_{X_t | X_0} = f_{Y_t | X_t} f_{X_t | X_0}$$

$$f_{\tau}^u(y, x) = \frac{1}{\nu\sqrt{2\pi}} \exp\left\{-\frac{1}{2\nu^2}(y-x)^2\right\} \frac{\beta^{\alpha\tau} (x-u)^{\alpha\tau-1} \exp\{-\beta(x-u)\}}{\Gamma(\alpha\tau)}$$

- **Common structure**

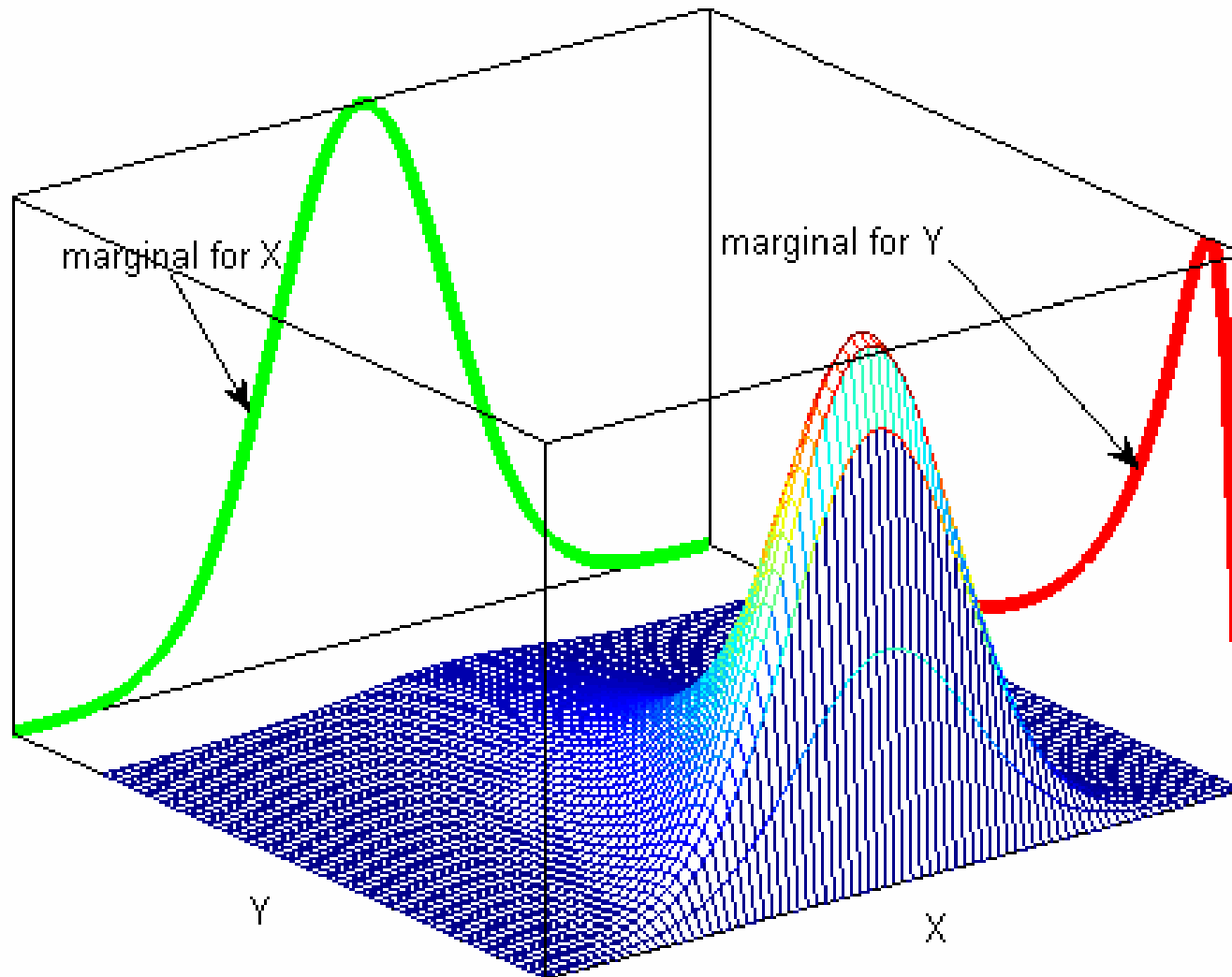
- **Underlying process**  $X_t$

- **Bivariate process**  $(X_t, Y_t)$

- **Transition density**  $f_{X_t, Y_t}^{u, v}(x, y)$

- **Optimisation**  $v_\tau(x, y) = \inf_{\tau > 0} \left\{ c_\tau(x, y) + \int_{A_0} v_\tau(u, w) f_\tau^{x, y}(u, w) du dw \right\}$

- **hard to determine the dependence structure of mv process**
- **easy to observe marginal processes (one variable at a time)**
- **correlation is not good enough**
- **use copulas**
- **the process is modelled in two parts**
  - the marginal distributions
  - the copula describes dependence
- **advantages**
  - marginals are observable
  - bounds on copulas are easily determined
  - copulas for transformed variables are readily obtained



**joint distribution**  $F_{\underline{X}}(\underline{x}) = F_{\underline{X}}(x_1, x_2, \dots, x_n)$

**we can observe the marginals**  $F_{X_1}(x_1), F_{X_2}(x_2), \dots, F_{X_n}(x_n)$

**define  $C$  by**  $F_{\underline{X}}(\underline{x}) = C[F_{X_1}(x_1), F_{X_2}(x_2), \dots, F_{X_n}(x_n)]$

**copula is distribution on unit cube**

$$C : [0, 1]^n \rightarrow [0, 1]$$

**with uniform marginals**

$$C_{U_i}(u) = u$$

## Frechet bounds

$$\max \left\{ \sum_{i=1}^{i=n} F_{X_i}(x_i) - (n-1), 0 \right\} \leq F_{\underline{X}}(x_1, x_2, \dots, x_n) \leq \min_{i=1..n} \{ F_{X_i}(x_i) \}$$

$$\max \left\{ \sum_{i=1}^{i=n} u_i - (n-1), 0 \right\} \leq C(u_1, u_2, \dots, u_n) \leq \min_{i=1..n} \{ u_i \}$$

## Denuit bounds

$$\max \left\{ \sum_{i=1}^{i=n} u_i - (n-1), 0 \right\} \leq \dots$$

$$C_{\theta_0}(u_1, u_2, \dots, u_n) \leq C_{\theta}(u_1, u_2, \dots, u_n) \leq C_{\theta_1}(u_1, u_2, \dots, u_n) \dots$$
$$\leq \min_{i=1..n} \{ u_i \}$$

## transformed variables

$$Y = h(\underline{X})$$

$$Z_2 = X_2$$

...

$$Z_n = X_n$$

## inverse

$$X_1 = g(\underline{Y}, \underline{Z})$$

$$X_2 = Z_2$$

...

$$X_n = Z_n$$

## generalized convolutions

$$\tau_{C,h} \left( F_{X_1}, F_{X_2}, \dots, F_{X_n} \right) (y) = \sup_{z_2, \dots, z_n} C \left\{ F_{X_1} \left( g(y, z_2, \dots, z_n) \right), F_{X_2} (z_2), \dots, F_{X_n} (z_n) \right\}$$

$$\rho_{C,h} \left( F_{X_1}, F_{X_2}, \dots, F_{X_n} \right) (y) = \inf_{z_2, \dots, z_n} C^d \left\{ F_{X_1} \left( g(y, z_2, \dots, z_n) \right), F_{X_2} (z_2), \dots, F_{X_n} (z_n) \right\}$$

**define**

$$F_0(y) = \tau_{C_0, h} \left( F_{X_1}, F_{X_2}, \dots, F_{X_n} \right) (y)$$

$$F_1(y) = \rho_{C_1, h} \left( F_{X_1}, F_{X_2}, \dots, F_{X_n} \right) (y)$$

**bounds are**

$$F_0(y) \leq F_{h(X)}(y) \leq F_1(y)$$

**percentiles**

$$F_1^{-1}(\alpha) \leq F_{h(X)}^{-1}(\alpha) \leq F_0^{-1}(\alpha)$$

- with copulas we can handle dependence without complete knowledge
- we get bounds on probabilities of interest

- **development of effective performance criteria**
- **current process models are too simple yet difficult**
  - improve process models
  - solve decision problems
- **develop the model of interventions  $d(x,y)$**
- **address multivariate process models using copulas**